

# Recent Developments and Cross-Calibration of Resonator-Based Techniques for Microwave and mmWave Materials Assessment

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12<sup>th</sup> International Conference on Microwave Materials and their Applications Mainz, 27 September 2023



#### (1) QWED celebrating 25 years in May 2022



(2) 75<sup>th</sup> birthday of W.Gwarek at MIKON 2022 (cake featuring pioneering paper of 1985)



All photos © QWED.

(1), (2) featured in IEEE Microwave Magazine, Dec. 2022, by R.Henderson, IEEE MTT-S President, "Let Them Eat Cake"

# 

Sale of 1000<sup>th</sup> resonator based on designs of J.Krupka



#### Prime Minister of Poland Award for QWED 1998



QWED' beginnning, founders (right to left): W.Gwarek, M.Celuch, M.Sypniewski, A.Wieckowski

Awarded by Prof. Jerzy Buzek Prime Minister of Poland 1997-2002 President of the European Parliament 2009-2012



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MMA2012



#### https://www.qwed.eu/mma2010/







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- 1. **QWED**: from Computational Electromagnetics to Modelling-Based Materials' Characterisation.
- 2. iNEMI: Setting-Up 5G/mmWave Benchmarking Projects.
- 3. Resume of Round-Robin Results of Resonator-Based Techniques for Characterising 5G Substrates.
- 4. Modelling: Interpretation of Measurements and Design of New Instruments.
- 5. Summary.
- 6. Invitations and Acknowledgements.



### QWED origins in Computational Electromagnetics

#### since 1980s...

IEEE- awarded research of Prof. Wojciech Gwarek on 2D FDTD modelling (with novel conformal meshing) DML

Fellow, **IEEE** THE INSTITUTE OF ELECTRICAL AND ELECTRONICS ENGINEERS. IN Certifies that

#### Woiciech Kazimierz Gwarek has been elected to the grade of Fellow tributions to the theory and applications of electromagnetic modelin

Pioneeer Award,

MICROWAVE THEORY AND TECHNIQUES SOCIETY In Recognition of Distinguished Service MIT-S Distinguished Microwave Lecturer Woiciech Gwarek for his lecture entitled Microwave passive circuit design without hardware prototyping how close it comes with state-of-art electromagnetic simulation On Behalf of the Administrative Committee of the IEEE Microwave Theory and Techniques Society Kail Varian Edward & Rezel

AT A

M.Celuch joins the above research, leading to PhD in 1996 1996 Beta-Version of QuickWave at Univ. Chalmers, Kent, Helsinki 1997 first commercial licences sold by QWED ... by 2000, QuickWave-3D by QWED used worldwide

Woiciech Gware

for industrial & research applications from RF to optical bands



### since 1998 annually at IEEE IMS

Anaheim, CA, 1999





2006



ED 

### QuickWave original applications in cosmic reseach & SATCOM

#### Septum polariser by SES

below: differential phase-shift

design & measurements: Saab Ericsson Space modelling: QWED, 1997

#### **E-plane Y-junction by NRAO**



[deg] 90 70 50 30 11 12 13 14 Freq.[G:



at centre frequency

### **Applications for Materials Processing with Microwaves**

Simple microwave heating benchmarks Design & analysis of real-life microwave oven cavities, incl. & microwave heating phenomena studies\* complicated cavity shapes and advanced feeding system\* heat transfer & load dynamics HFSS v11 Load rotation & arbitrary . movement during heating Source parameters tuning – regime for solid state sources **Temperature dependence of** material parameters QuickWave 3D & BHM **Freezing to file** the state of the simulation Courtesy of Whirlpool Inc. – Whirlpool MAX oven 0.8 0.6 0.8 |S11| **De-freezing on** 0.6 0.4 |S11| With QuickWave EM arbitrary computer computation as fast as 0.4 0.2 & at convenient QuickWave-3D 1 min 18s on a low-cost CST MS time 0.2 video card – supporting 2.35 2.39 2.43 2.47 2.51 2.55 all graphic cards with –QuickWave-3 Frequency (GHz) -HFSS OpenCL 2.2 2.4 2.6 2.8 Frequency (GHz) M.Celuch, P.Kopyt & M. Olszewska-Placha in eds. M. Lorence, P. S. Pesheck, U. Erle, Development of packaging and products for use in microwave ovens,

2nd Ed. Elsevier 2020.

### Material Measurements coming to QWED

#### since 1980s...

awarded research of Prof. Jerzy Krupka (IEEE Fellow) on dielectric resonators (best known: Split-Post Dielectric Resonator)





by Donald Tusk Prime Minister of Poland 2007-2014 President of the European Council 2014-2019

#### ... by early 2000s:

QWED commercialises the SPDRs endorsement by Agilent / Keysight publication of standard IEC 61189-2-721:2015

Agilent Both IEEE IMS 2006, San Francisco, CA



MMA-2010, Warsaw PL co-organised by QWED & Warsaw Univ.Tech.



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### Popular Resonators Offered by QWED

SPDRs for laminar dielectric materials typical units: 1.1 GHz -15 GHz



T. Karpisz, B. Salski, P. Kopyt, and J. Krupka, doi: 10.1109/TMTT.2019.2905549.

FPOR 20 -120 GHz





### **Bridging Computer Modelling with Material Measurements**



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## Why Resonators for Material Measurements?

Circuit theory interpretation (for newcomers to the field):





given fixed strength of Signal(in), at resonance Signal (out) is strongest

given fixed strength of Uin, at resonance  $U_R$  is strongest ( $U_{LC}$ =zero)



### **Examples of canonical examples of resonators (**for newcomers to the field**)**



→ application of cavities to Dk measurements appears straightforward!

(but cavity losses should be minimised & 100% filling factor is difficult to achieve)





### **QuickWave model of a cylindrical cavity**

#### TM011 mode

#### TM021 mode



• easier standard manufacturing



### How do dielectric resonators work (with QuickWave illustration)

**Dielectric resonator** (top left) **as a multimode device** (see transmission (



as a multimode device (see transmission diagramme, top centre) including TE01 mode (top right) and many higher modes (lower row)





### Split-Post Dielectric Resonator method – as illustrated by QucikWave



- resonant mode with EM fields mostly confined in and between those ceramic posts → minimial losses in metal enclosure
- H-field is only vertical at the side wall of the enclosure  $\rightarrow$  only circumferential currents in side wall  $\rightarrow$  no radiation through slot
- E-field tangential to SUT  $\rightarrow$  air slots between SUT and posts have negligible effect
- easy SUT insertion through slot, no dismatling, NDT method



# Which Scanner:

**SPDR** 

or

# **iSiPDR**

cavity



| Table 2. Typical ranges of applications of SPDRs and SiPDRs |                           |   |  |  |  |
|---|---------------------------|---|--|--|--|
|   | Conductivity [1/(Ωm)]     | Resistivity [ $\Omega$ cm]                  | Surface resistivity<br>[Ω/sq]              |  |  |
| Range od SPDR<br>applications                               | 2 10 <sup>-3</sup> to 0.5 | from 2 10 <sup>2</sup> to 5 10 <sup>4</sup> | from 2 $10^3$ to $10^7$                    |  |  |
| Range of SiPDR<br>applications                              | 0.1 to 10 <sup>6</sup>    | from $10^{-4}$ (*) to $10^{3}$              | from 10 <sup>-1</sup> to 2 10 <sup>4</sup> |  |  |

Resonator designs after:

J. Krupka and J. Mazierska, IEEE Trans. Instr. Meas., 2007, doi: 10.1109/TIM.2007.903647

#### CAD models and EM field distribution: QuickWave<sup>™</sup> software by QWED



### 2D 10 GHz SPDR Scanner for Low-Loss Dielectrics



### **Modelling-Based Materials' Characterisation Setup**



2D scanner designed with a modified 10 GHz SPDR Finalist of the European Innovation Radar Prize 2021

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### Patterned PEDOT:PSS sample courtesy MateriaNova, Belgium





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### 2D 10 GHz iSiPDR Scanner for Resistive Sheets



### **Modelling-Based Materials' Characterisation Setup**



 85 – 160 [Ω/sq.]

2D iSiPDR scanner based on inverted 10 GHz SiPDR

Example application:

battery anodes before & after cycling (SEI formation).



# Now coming to iNEMI projects...





### 5G/mmWave Materials Assessment and Characterization

further referred to as "5G Dielectrics" our "5G Substrates" project

- 5G: Common to only think in terms of 'radio' applications
- '5G' extends beyond wireless applications

| CPU Clock Speeds          |                               | High Speed I/O |   |   |        |
|---------------------------|-------------------------------|----------------|---|---|--------|
|                           |                               |                |   |   | $\neg$ |
| <1GHz                     | 3GHz 4GH;                     | z — 5GHz —     | —24-28GHz——                                       | 37-40GHz 64-71G   | Hz     |
| 600MHz (2x35MHz) 2.5GHz ( | LTE B41) 3.55-3.7 GHz 3.7-4.2 | GHz 5.9-7.1GHz | 24.25-24.45GHz<br>24.75-25.25GHz<br>27.5-28.35GHz | 37-37.6GHz<br>37.6-40GHz<br>4 <u>7.2-48.2GH</u> z 64-71GH | łz     |
| 600MHz (2x35MHz)          |                               |                | 27.5-28.35GHz                                     | 37-37.6GHz<br>37.6-40GHz 64-71GH                          | ٠lz    |
| 700MHz (2x30 MHz)         | 3.4-3.8GHz                    | 5.9-6.4GHz     | 24.5-27.5GHz                                      |   |        |
| 700MHz (2x30 MHz)         | 3.4-3.8GHz                    |                | 26GHz   |   |        |
| 700MHz (2x30 MHz)         | 3.4-3.8GHz                    |                | 26GHz   |   |        |
| 700MHz (2x30 MHz)         | 3.46-3.8GHz                   |                | 26GHz   |   |        |
| 700MHz (2x30 MHz)         | 3.6-3.8GHz                    |                | 26.5-27.5GHz                                      |   |        |
|                           | 3.3-3.6GHz                    | 4.8-5GHz       | 24.5-27.5GHz                                      | 37.5-42.5GHz  |        |
|                           | 3.4-3.7GHz                    |                | 26.5-29.5GHz                                      |   |        |
|                           | 3.6-4.2GHz                    | 4.4-4.9GHz     | 27.5-29.5GHz                                      |   |        |
|                           | 3.4-3.7GHz                    |                | 24.25-27.5GHz                                     | 39GHz   |        |

Src: Urmi Ray, 5G/High Frequency Materials Characterization Challenges and Opportunities, EMA 2021, S13

- Many forward-looking wired applications need material data spanning DC to 100+GHz
- Dielectric constant measurements are key enables for many different industries & technologies





### **Industrial Motivation**

- Traditional methods of microwave design rely on trimming & tuning difficult to tolerate in today's environment...
- Faster & less costly "virtual prototyping" is achieved with today's modelling & simulation tools...
- ...but accurate material data is still required
- ...errors in materials' characterisation limit accuracy of modelling resulting in time consuming iterations



"errors may cost \$10's of millions for a single program, or worse, unexpected product failures"





### **Gaps & Practical Challenges**

No standards & SRMs for mmWave Permittivity measurements >20 GHz:

• Challenges for ISO and quality control

Few vendors for mmWave Permittivity measurement equipment >10 GHz:

- Explain vendor to vendor differences
- Whom to trust?
- On whom to rely?

#### Useful 5G materials are typically very low loss:

• Eliminates many traditional transmission line techniques

Increasing frequency:

- Severe limitations on sample thicknesses
- Incompatible sample dimension requirements between techniques
- Higher sensitivity to operator









### First Round-Robin

Sample Material Requirements

- Stable, Low loss
- Low moisture absorption / temperature dependency
- Isotropic

٠

• Good mechanical & handling properties

#### 1<sup>st</sup> Project Stage

- Precision Teflon
  - Cyclo Olefin Polymer
- 2<sup>nd</sup> Project Stage IndustrialRexolite Automotive
- Fused Silica

#### 10 Laboratory Round Robin



Results for in-plane measurements first reported at EuMW 2021 3 resonator techniques 2 sample kits 3 labs, each using 2+ techniques



#### Techniques Included

- Split Post Dielectric Resonator
- Split Cavity Resonator
- Fabry-Perot
- Balanced Circular Disk Resonator
- $\rightarrow$  Frequency Span : 10GHz 100GHz with overlaps

10 Sample Kits Created

• Sample sizes 35 mm x 45 mm, 90 mm x 90 mm

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### Split Cylinder Resonator (SCR) - Basics



In-plane Electric field is applied to Sample



Split cylinder resonator (SCR)



Discrete frequency points from 10 GHz up to 80 GHz

- High measurement precision ٠
- Can be sensitive to many user errors ٠
- Typically interpolated to 5G mmWaves ٠
- Typically in-plane component of permittivity ٠
- Typical sample thicknesses around 100 um .
- Support temperature sweep measurement ٠
- IPC-TM-650 2.5.5.13 .
- https://www.keysight.com/us/en/assets/7018-٠ 06384/brochures/5992-3438.pdf



### **Measurement Procedure: SCR**



### Split-Post Dielectric Resonator (SPDR): Basics & Standard



- resonant mode with EM fields mostly confined in and between those ceramic posts
   → minimial losses in metal enclosure
- H-field is only vertical at the side wall of the enclosure → circumferential currents
   → no radiation through slot
- E-field tangential to SUT
- ightarrow air slots between SUT and posts have negligible effect
- easy SUT insertion through slot, no dismatling



### **Measurement Procedure: SPDR**



### Fabry-Perot Open Resonator (FPOR): Basics & Standard



Fabry-Perot open resonator (FPOR, also called opencavity)

Discrete frequencies between 20 GHz up to 110 GHz

- High measurement precision
- Can be sensitive to many user errors
- Uncertainty increases with increasing frequency
- Typically in-plane component of permittivity
- JIS R1660-2
- https://www.gwed.com.pl/resonators.html#ResonatorFPOR
- https://www.keysight.com/main/editorial.jspx?cc=US&lc=eng&cke y=2276755&nid=null&id=2276755

T. Karpisz, B. Salski, P. Kopyt, and J. Krupka, "Measurement of Dielectrics From 20 to 50 GHz With a Fabry–Pérot Open Resonator," IEEE Trans. Microw. Theory Tech., May 2019, doi: 10.1109/TMTT.2019.2905549.

T. Karpisz, B. Salski, P. Kopyt, and J. Krupka, "Coordinate transformation approach to the solution of the Fabry-Perot open resonator," in 2018 22nd International Microwave and Radar Conference (MIKON), May 2018, doi: 10.23919/MIKON.2018.8405291.



### Fabry-Perot Resonator Open Resonator

Measuring in-plane anisotropy:



Resonances detected for **BoPET** sample (t = 0.100 mm), turned in xy plane.

T.Karpisz et al, "Measurement of in-plane anisotropy of dielectric materials with a Fabry-Perot open resonator", Proc. MIKON 2020.





### **Measurement Procedure: FPOR**





2. Measure "empty FPOR" (resonant frequency and Q-factor at M..N modes)

1. Connect the FPOR to VNA and PC with control app.

PC app invoked and controlled measurement – fully automatic Total measurement time: 10min

5. Material parameters at consecutive frequencies (modes) are extracted automatically





3. Insert the sample into FPOR

4. Automatic procedure finds M..N modes of sample-loaded FPOR





### First Round-Robin Results: Consistency

#### 3 labs, 3 techniques 14 laboratory setups

#### **Resonators:**

Intel - SCR at 10 / 60 GHz and SPDR at 10/ 20 GHz Keysight - SCR at 10 / 20 / 28 / 40 / 80 GHz QWED - SPDR at 10/ 15 GHz and FPOR over 10-110GHz

#### VNA, software:

Intel, Keysight – benchtop VNA with Keysight Option N1500A QWED FPOR – benchtop VNA with customised FPOR software QWED SPDR – handheld VNA , extraction based on abs(S21)



visually good results, with reference to standards and practices in the microwave range

(e.g. IEC 61189-2-721:2015 for SPDRs < 20GHz dictates 0.3% for Dk assuming perfect determination of thickness,

relaxed to 1% in industrial practice)

![](_page_32_Figure_11.jpeg)

### First Round-Robin Results: Repeatability

#### 3 labs, 3 techniques, 14 laboratory setups 1 operator per setup

Intel - SCR at 10 / 60 GHz and SPDR at 10/ 20 GHz, Keysight - SCR at 10 / 20 / 28 / 40 / 80 GHz QWED - SPDR at 10/ 15 GHz and FPOR over 10-110GHz.

![](_page_33_Figure_3.jpeg)

![](_page_33_Figure_4.jpeg)

repeatability of SCR ±1% repeatability of SPDR, FPOR better than ±0.5%

each symbol denotes an average of 16 measurements; error bar = repeatability = triple of standard deviation

![](_page_33_Figure_8.jpeg)

### First Round-Robin Results: Discussion

3 labs, 3 techniques, 14 laboratory setups

Intel - SCR at 10 / 60 GHz and SPDR at 10/ 20 GHz, Keysight - SCR at 10 / 20 / 28 / 40 / 80 GHz QWED - SPDR at 10/ 15 GHz and FPOR over 10-110GHz.

![](_page_34_Figure_3.jpeg)

![](_page_34_Figure_4.jpeg)

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#### > 40GHz 2x increase in Df compared to 10GHz

![](_page_34_Picture_7.jpeg)

### Round-Robin – 2<sup>nd</sup> Material

#### 3 labs, 3 techniques, 14 laboratory setups

Intel - SCR at 10 / 60 GHz and SPDR at 10/ 20 GHz, Keysight - SCR at 10 / 20 / 28 / 40 / 80 GHz QWED - SPDR at 10/ 15 GHz and FPOR over 10-110GHz.

![](_page_35_Figure_3.jpeg)

Dk spread < 1% (within ± 0.5% from average)

### Divergence of BCDR Measurements More Pronounced for Fused Silica\*

![](_page_36_Figure_1.jpeg)

\* for further info on "iNEMI 5G SRM Project", see <mark>talk (5.47)</mark> by Marzena this afternoon

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![](_page_36_Picture_5.jpeg)

### Notes on **BCDR**

![](_page_37_Picture_1.jpeg)

Open the resonator

![](_page_37_Picture_3.jpeg)

Set lower side sample

### Disclaimer: this slide is NOT about QWED designs

Note: in the iNEMI benchmarking, different BCDRs are used by two project partners. The photos and figures on this slide concern:

https://www.keysight.com/us/en/assets/7120-1214/flyers/N1501AE11-67-Balanced-Type-Circular-Disk-Resonator-BCDR.pdf

![](_page_37_Picture_8.jpeg)

Set shim sheet

![](_page_37_Picture_10.jpeg)

Set center electrode

![](_page_37_Picture_12.jpeg)

Set upper side sample

![](_page_37_Picture_14.jpeg)

Close the resonator

![](_page_37_Picture_16.jpeg)

Clamp and measure

![](_page_37_Picture_18.jpeg)

Resonant Freq. vs. Permittivity @ disc diameter 15mm

![](_page_37_Figure_20.jpeg)

### Notes on BCDR: Air slots in In-Plane and Out-of-Plane Measurements – Small Air Slot in a Paralel-Plate Capacitor

![](_page_38_Figure_1.jpeg)

<mark>in-plane:</mark> even for high Dk dielectrics, % error in Dk is significantly smaller that % of air gap <mark>out-of-plane:</mark> % error in Dk increases faster than linearly with % air gap (here, 10% gap –> ~40% error in Dk of sapphire)

![](_page_38_Figure_4.jpeg)

### Notes on BCDR: QWED's Electromagnetic Insight

![](_page_39_Figure_1.jpeg)

### Notes on BCDR: QWED's Test Design

![](_page_40_Picture_1.jpeg)

Our BCDR prototype has been manufactured and works.

Measurements confirm BCDR sensitivity to air gaps, even small, caused by roughness of metallic surfaces (electrodes). Ths is not a problem in SPDR (and other standard out-of-plane measurements)!

![](_page_40_Figure_5.jpeg)

### QWED's Novel Design for Thick Samples

patent filed last week

![](_page_41_Picture_2.jpeg)

### Challenges in Measuring (Thick) Industrial Samples

Relevant industrial samples, provided in iNEMI 5G Dielectrics" project for testing for automotive radar applications, could NOT be measured at mmWaves – they were only measured with low frequency SPDR (@1.1 GHz).

#### This is because all the available resonator techniques impose limits on sample thickness:

- mechanical related to design of a particular instrument,
- electromagnetic due to undesired modes appearing in the measurement band.

#### Typically:

- SPDR allows thicker samples that SCR, for given frequency,
- but SPDRs are offered only for lower frequencies.

#### Sample Thickness - SCR

![](_page_42_Figure_9.jpeg)

#### Example:

In 15GHz SPDR, slot 0.6mm, 0.6mm sapphire can be measured. In SCR even 10GHz, sapphire sample would need to be < 0.4mm

- Dk is higher,

- frequency is higher.

Typically: sample needs to be thinner when:

![](_page_42_Figure_12.jpeg)

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### QWED's Novel SCR with Q-Choke

![](_page_43_Picture_1.jpeg)

### Modelling of SCR without and with Q-Choke

![](_page_44_Figure_1.jpeg)

### Measurements in Q-Choked SCR

#### 1.2 mm sapphire easily measured at 20 GHz

![](_page_45_Figure_2.jpeg)

![](_page_45_Picture_4.jpeg)

# Conclusions

1. The talk has reported on iNEMI projects concerning assessement of materials and benchmarking of material measurement techniques for 5G/mmWave applications.

2. The "5G Substrates" project initiated rigorous benchmarking for substrate materials:

- assembled tens of thousands of measurements by 11 labs with 4 techniques (in different implementations),
- techniques: 3 for in-plane (SPDR, SCR, FPOR) and 1 for out-of-plane (BCDR) permittivity measurement,
- samples: 2 sample sizes that cover all the techniques: 35mm x 45 mm and 90mm x 90mm,
- materials: started with COP (186 μm ) and Teflon (126 μm, 50 μm) ; then fused silica, rexolite, and industrial (automotive, electronics,..).

3. For inter-lab, inter-technique comparisons, average of 16 measurements (at a given lab by a given technique for a given sample) was used.

For in-plane techniques:

- Dk spread (between the 3 metrologies) < 1% (2% incl. non-standard outliers),
- QWED's SPDR and FPOR well consistent, SCR and other FPORs are sometimes outliers,
- sample-to-sample variation more significant than lab-to-lab or technique-to-technique (presumably sample thickness variations),
- for COP at f > 40GHz, 2x increase in Df demonstrated compared to 10GHz loss.

For out-of-plane (BCDR), Dk measurements:

- diverges from in-plane for (presumably) isotropic samples (up to 3-7% for fused silica),

- vary in frequency,

the effects remain to be explained by BCDR designers / vendors or by use of other out-of-plane measurements.

4. The work continues in ongoing projects, including on "5G Copper Foils" and "5G SRMs" (see talk 5.47)

![](_page_46_Picture_18.jpeg)

# Conclusions

- 1. QWED material measurement methods and instruments have been presented:
- for different frequency bands (within 1.1 -120 GHz),
- for different materials (substrates, coper foils, liquids, 2D materials,...)

2. Insight into the physics behind the applied methods and instruments has been provided, by modelling in QuickWave<sup>™</sup> simulation software by QWED.

3. In both qulitative and quantitative terms, the presented methods and instruments prove advantageous, in the context of the international benchmarking inititaives coordinated by iNEMI.

- 4. Recent developments have been indicated:
- 2D imagining of dielectric surfaces of resistive films with 2D SPDR or iSiPDR scanners,
- BCDR for out-of-plane measurements (and testing of the BCDR concept),
- Q-Choked SCR for 20 GHz (scheduled 304, 40, 50 GHz) alleviating the existing limits on sample thickness.

5. QWED is happy to design custom-made instruments and enter into joint R&D projects!!!

![](_page_47_Picture_11.jpeg)

## Invitations & Acknowledgements.

![](_page_48_Picture_1.jpeg)

9/26/2023 to 9/27/2023 EDT

Packaging Tech Topic

#### 26 SEP

Series: Toward The Physical Reliability Of 3D-Integrated Systems

9:00 AM to 10:00 AM EDT

27 SEP 8:30 AM to 9:30 AM CET

#### 27 RESCHEDULED:

SEP SEP SEP SEP SEP Seminar On Humidity Robustness And Isolation Coordination For E-Mobility

9:00 AM to 4:30 PM CET

#### 13 OCT Reliability And Standards For

Automotive Electronics

8:30 AM to 5:30 PM HKT

View All Events

#### 5G/mmWave

- <u>mmWave Permittivity Reference Material Development</u>
- Also see Roadmap: 5G/6G mmWave Materials and Electrical Test Technology Roadmap (5G/6G MAESTRO)

#### Board Assembly

- Bi-Sn Based Low-Temperature Soldering Process and Reliability
- Characterization of Third Generation High-Reliability Pb-Free Alloys
- <u>Conformal Coating Evaluation for Environmental Protection against Corrosive Environments, Phase 3</u>
- <u>Connector Reliability Test Recommendations, Phase 3</u>
- Electromigration of SiBn Solder for Second-Level Interconnect
- QFN Package Board Level Reliability

#### Optoelectronics

Best Practices for Expanded Beam Connectors in Data Centers

#### Packaging

- Impact of Low CTE Mold Compound on Second-Level Board Reliability, Phase 2
- Low Temperature Material Discovery and Characterization for First Level Interconnect
- Moisture Induced Expansion Metrology for Packaging Polymetric Materials Project, Phase 1
- PLP Fine Pitch Substrate Inspection/Metrology, Phase 4
- RDL Adhesion Strength Measurement Project
- <u>Warpage Characterization and Management Program</u>
  - High Density Interconnect Socket Warpage Prediction and Characterization

#### PCB & Laminates

- <u>Reliability & Loss Properties of Copper Foils for 5G Applications</u>
- PCBA Materials for Harsh Environments, Phase 2
- Hybrid PCBs for Next Generation Applications
- PCB Characterization for CAF and ECM Failure Mitigation
- PCB Connector Footprint Tolerance

# International Electronics Manufacturing Initiative

https://www.inemi.org/in%20progress

![](_page_49_Picture_39.jpeg)

### https://emmc.eu/

### Model Development

Home | Focus Areas | Model Development

### Objectives

### The European **Materials Modelling Council**

The non-profit Association, EMMC ASBL, was created in 2019 to ensure continuity, growth and sustainability of EMMC activities for all stakeholders including modellers, materials data scientists, software owners, translators and manufacturers in Europe The EMMC considers the integration of materials modelling and digitalisation critical for more agile and sustainable product development.

EMMC 🛇

• Promote the use of materials modelling in industry

• Promote actions and activities to enhance the capabilities of materials modelling

EMMC considers the integration of materials modelling & digitalisation critical for more agile and sustainable materials & product development.

> New and improved materials and the use of existing materials in new applications are a key factor for the success and sustainability of European industry and society in general.

FOCUS AREAS C RESOURCES NEWS EMMC 2023 EVENTS JOBS FORUM

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![](_page_50_Picture_14.jpeg)

![](_page_50_Picture_15.jpeg)

CONTACT Q

LOG IN | REGISTER

![](_page_51_Picture_0.jpeg)

![](_page_52_Picture_0.jpeg)

to my Father, MSc in engineering with PhD in economics, Sybirak - survivor of Soviet deportation to Siberia

1° because it is his birthday

2° because I find myself more & more following his footsteps

3° with an appeal for a sustained response to Russia's invasion of Ukraine to prevent Siberia happening to my grandchildren

![](_page_52_Picture_5.jpeg)

# Acknowledgements

![](_page_53_Picture_1.jpeg)

The authors wish to thank all the partners of the iNEMI 5G project for their great collaboration in the benchmarking activities.

| Our special thanks | go to:  |
|--------------------|---|
| Coordinator:       | Urmi Ray (iNEMI),   |
| Industry:          | Mike Hill (Intel), Hanna Kahari (Nokia), Charles Hill (3M)                    |
|                    | Say Phomakesone and Daisuke Kato (Keysight)                                   |
| NMIs:              | Nate Orloff and Lucas Enright (NIST), Chiawen Lee and Chang-Sheng Chen (ITRI) |

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![](_page_53_Figure_5.jpeg)